

A Maintenance-Oriented Board Testing Approach

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Abstract

We present an ongoing work in the domain of mixed-signal board maintenance testing, supported by an industrial case study. We propose a method providing a partial automation and a help for the board maintenance testing and diagnosis stages. It is validated by the implementation of a prototype tool.

1 MOTIVATION

The overall process of mixed-signal board testing needs to be mastered more efficiently. A large amount of work has already been done concerning testing during conception phases (design for testability) and production. The main part of these works deals with digital boards, some others with analogue boards, and quite a few with mixed-signal boards [1, 2]. As a result, tools exist for digital boards testing, analogue boards testing, or some specific electronic components testing. One may notice that, surprisingly, not much interest has been thrown into testing during the maintenance stage. Indeed, the maintenance process has its own specificities and testing problematic, different from these of conception or production. Our work is related to this aspect and concerns more particularly the maintenance testing of mixed-signal boards.

First, we explain the specificity of maintenance testing. Then, we sketch the main ideas of our method in this context. Next, some more details on the method and its application via a prototype for mixed-signal boards testing are given. Results on

an industrial case study are then presented. A discussion on future work ends the paper.

2 MAINTENANCE CONTEXT

The maintenance stage is one of the step constituting the life cycle of a manufactured product, which begins after the development/production cycle, and thus does not belong to it. This cut is not artificial and explains why methods conceived for the development stage are not well suited to maintenance. For example, when a failure occurs in a product in use for several years, it is often long and difficult to repair it. Although it is always possible to throw away a faulty component/board and just replace it by a new good one in the case of cheap large series, there are still some more complex, particular technology, valuable components/boards that really need to be repaired. Actually, in most cases, specifications and test data for the product are missing. It is also rare that the development/production team for this product is still there to help. The one in charge of the diagnosis and repair has then to face a complex problem, often in an empirical way, with no tool available to guide or automate at least a part of his work.

In maintenance, one may distinguish preventive maintenance from corrective maintenance. Corrective maintenance is, as in the above example, to be able to deal with failures when they occur, sometimes very quickly. Preventive maintenance consists in checking periodically the correct behaviour of components, and may seem more time-consuming than corrective maintenance. However, by anticipating incorrect behaviours, it allows to guarantee a higher level of confidence in the product and thus a lower need for corrective maintenance.

As far as testing is concerned, corrective maintenance may be viewed as a local approach whereas preventive maintenance is more global. In the first case, tester is interested in one behaviour (to reproduce the target failure), and in the second case, he has to check the set of all behaviours of the board. Independently of their nature, these two kinds of maintenance are in great need of generic testing methods and tools.

The method we introduce next was first designed for corrective maintenance needs, and offers a well-adapted precision level according to this aim. In adds, it may also constitute a help for preventive maintenance.

3 MAIN IDEAS

Our final goal is to propose a method, supported by a (semi-)automatic tool, providing a help to the board maintenance testing and diagnosis stages. We thus have to formalise the testing and diagnosis data and processes, taking into account the industrial context and practices. Two main aspects are to be considered. First, mixed-signal boards testing practitioners have some know-how related to their experience and skills in the testing process. We think that this knowledge has to be included in the tool. Second, the tool must match the background of testing practitioners in order to be really useful and used. This implies formalisms which are intuitive or well-known to testing engineers. Because of the lack of tools dealing with mixed-signal components, we pay special attention to the modelling and testing of mixed-signal boards.

Figure 1 and Figure 2 sketch our complete method process flow.

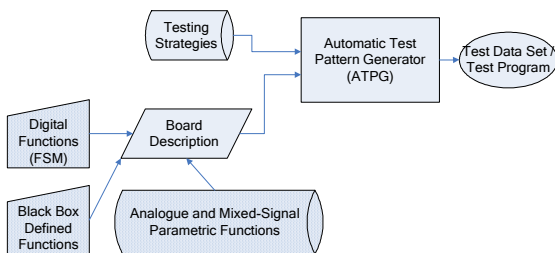


Figure 1: Test data set generation process flow

Figure 1 shows how to generate a test data set for a board given some testing strategies and a description of the (correct) board. This test data set may then be automatically translated into a test program expressed in an Automatic Test Equipment (ATE) language. The test program is the test data set instrumented with ATE primitives and an oracle. The oracle compares the real outputs of the test with the expected ones, and is thus able to decide and list which tests fail.

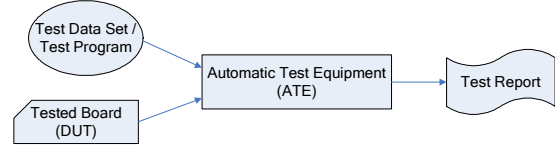


Figure 2: The board testing process flow

Figure 2 presents how to obtain a test report by running the test program on the maybe faulty board, using an ATE. The first information in the test report is the verdict: the board passed the tests or not. If not, for each failed test, the test report indicates the real and expected results, and the possibly faulty functional blocks. This ends the testing stage and is the departure point of the diagnosis stage. Depending on the required grain of diagnosis, one can stop there and just replace by good ones the components corresponding to faulty blocks. For more precise diagnosis, the method provides some functions that test more specifically the internal behaviour of a functional block (branch, state and path testing and coverage in an FSM context).

4 METHOD AND PROTOTYPE

We have implemented the ideas illustrated on Figure 1 in a prototype tool. This prototype provides a Graphical User Interface (GUI) allowing high level topological description of a mixed-signal board. In addition, the GUI includes some facilities for the choice of a testing strategy, for the description of the board-ATE connection and for the description of data (signals) flow.

A mixed-signal board is modelled as a set of connected functional blocks (each block identifies a function that can either be digital, analogue or mixed-signal). A functional block expresses a function, and does not need to correspond exactly to one of the physical components of the board. Indeed, most of the time it involves a set of such physical components. The description of the board is thus made at two levels: the board level and the block level as illustrated by Figure 3.

The prototype proposes different ways for defining functional blocks. The first one is dedicated to digital functions, the second to analogue or mixed-signal functions, and the third to black box functions. To define a digital function, the user describes the behaviour of the block using a finite state machine (FSM) formalism. In the second case, the user selects a function in a library of analogue and mixed-signal common components. Due to the specificity of maintenance testing, the prototype also allows black box functions. This kind of definition has to be used when absolutely no information on the board behaviour is

available. In practice, it is therefore possible to learn from a known good board a test data set characterising the board. This description is used in a black box definition. Even though using this description reduces the power of the method at the board level, it is some time mandatory to use it.

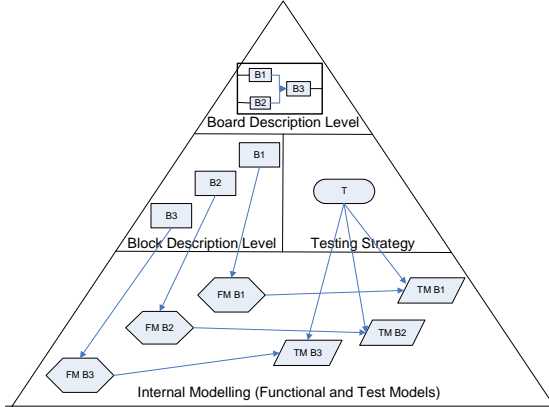


Figure 3: The architecture of the prototype

To generate more accurate test data than that obtained just from a board behaviour specification, we use testing strategies in add of the functional description of the board. A testing strategy expresses behaviours or faults that have to be specifically targeted by the generated test data set. The prototype relies on some basic predefined testing strategies (this usefully benefits from cross-fertilisation with testing practitioners), but it also allows to describe and use its own specific testing strategy.

From an internal point of view, the different kinds of blocks (digital, analogue or mixed-signal) are treated homogeneously. They are each associated to a functional model and a test model, expressed as communicating finite state machines (cf. Figure 3). Actually, the test model is automatically inferred from both the functional model and the chosen testing strategy (excepted in the case of black box components where the functional and test models are the same, the testing strategy being already part of this model). One can view the test model as a particular instantiation of the functional model. Nevertheless, both models are needed to achieve automatic test data generation.

We define the generated board test data set as the optimized union of all blocks test data sets. A block test data set is obtained by transition coverage of its test model and full upstream and downstream propagation through other blocks functional models to primary inputs and outputs. The aim of the optimization is to reduce the size of the test data set.

The problem of test data generation is faced using constraint logic programming (CLP) and classical algorithms for finite state machines (transition

coverage, state coverage, path coverage). In the prototype, test data are represented in a symbolic way, using ranges of values instead of one instantiated data. It is essential to work on a symbolic representation of data for the validity and efficiency of the approach. The instantiation of test data is only obtained at the end, on demand from the user, or automatically to derive a test program for a specific ATE.

Most of the prototype is written in C++, excepted the part concerning testing strategies that is implemented using constraint logic programming, with the ECLⁱPS^e solver [3].

The prototype has been validated on two first industrial case studies: the “Tachy board” [4] and the “Filter Command Board“, which are mixed-signal boards. We detail the application of the method on the “Filter Command Board” in the next section.

5 CASE STUDY

We first present the board involved in the case study. Then, we give the test data set obtained applying our method. More details on this case study modelling and testing are presented in [5].

5.1 Board description

The “Filter Command Board” (FCB) is a mixed-signal board (depicted in Figure 4) and is part of a telecommunication system. We describe shortly the inputs/outputs and the functionality of this board.

FCB has the following inputs/outputs signals:

- one serial digital input (SDI),
- one clock input (CK),
- one copy command (Copy),
- one transfer command (E/D),
- one serial digital output (SDO)
- eight digital outputs (DO),
- sixteen analogue outputs (AO1 and AO2).

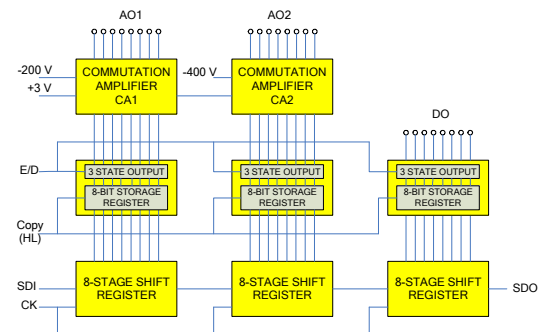


Figure 4: The Filter Command board

FCB digital part is made of:

- three 8-stage shift registers serially loaded into SDI on the rising edge strobe,
- three 8-bit storage registers parallel loaded from shift registers on the rising edge of the Copy signal,
- three 3-state buffers enabling /disabling digital output data with E/D signal.

FCB mixed-signal part is made of two commutation amplifiers CA1 and CA2. Each amplifier has height digital inputs and height analogue outputs. The commutation table for each input/output is given in Table 1.

	CA1	CA2
0	3 V	3 V
1	-200 V	-400 V

Table 1 : The commutation table

The main function of the FCB is to command weight filters connected to the commutation amplifiers outputs A01 and A02. Digital outputs DO and SDO command other modules in the system.

5.2 Board testing

We present here the test data sequences (and associated expected outputs). The final board test data set is:

$$\text{FCB test data set} = \{DT_{24}, DT'_{24}, DT''\}$$

with:

$DT_1 = (\text{data} = 1, \text{valid} = 1, \text{clock} = \text{top}, \text{copy} = \text{top2})$
and $R_1 = (-200, X \dots X)$

$DT_i = (DT_{i-1} + (\text{data} = X, \text{valid} = 1, \text{clock} = \text{top}, \text{copy} = \text{top2}))$ and $R_i = (X \dots X, -200/-400/1, X \dots X)$

$DT'_1 = (\text{data} = 0, \text{valid} = 1, \text{clock} = \text{top}, \text{copy} = \text{top2})$ and $R'_1 = (3, X \dots X)$

$DT'_i = (DT'_{i-1} + (\text{data} = X, \text{valid} = 1, \text{clock} = \text{top}, \text{copy} = \text{top2}))$ and $R'_i = (X \dots X, 3/0, X \dots X)$

$DT'' = (\text{data} = X, \text{valid} = 0, \text{clock} = \text{top}, \text{copy} = \text{top2})$
and $R'' = \text{« no information »}$ (high-impedance state).

This test data set is made of three sequences, the first two of size 24, the third one of size 1. It covers all the possible values for the 25 outputs, and the particular case of the transfer command set to 0.

6 CONCLUSION AND FUTURE WORK

We have presented a method for mixed-signal board testing, designed to face the specificities of maintenance testing. Some aspects have been validated such as the functional approach at all levels, the homogeneous modelling formalism (for digital, analogue and mixed-signal functions) and the testing strategies. The prototype is already able to generate expected test data (thus completing the first part of the method, cf. Figure 1) for the boards involved in the case studies.

Further work is needed to validate our complete approach and prototype, and its real impact on diagnosis. In particular, the second part of the method (depicted in Figure 2) is not yet implemented and needs an important effort as it implies the construction of a physical board, dedicated to the application of our method on a specific ATE.

Future work includes more experimentation of the method on other types of boards, but first results are encouraging, reinforcing the idea that at least semi-automatic testing of mixed-signal boards is feasible. This kind of tool would respond to a real need in the industrial community.

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